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**TABLE OF CONTENTS**


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<b><u>Section</u></b>	<b><u>Page</u></b>
<b>1. Electrical Specifications</b> .....	<b>4</b>
<b>2. Typical Application Schematic</b> .....	<b>14</b>
<b>3. Bill of Materials</b> .....	<b>15</b>
<b>4. Functional Description</b> .....	<b>16</b>
4.1. Overview .....	16
4.2. Operating Modes .....	16
4.3. FM Receiver .....	17
4.4. AM receiver .....	17
4.5. Stereo Audio Processing .....	17
4.6. De-emphasis .....	17
4.7. Stereo DAC .....	17
4.8. Soft Mute .....	18
4.9. RDS/RBDS Processor (Si4731 Only) .....	18
4.10. Tuning .....	18
4.11. Seek .....	18
4.12. Reference Clock .....	18
4.13. Control Interface .....	18
4.14. GPO Outputs .....	20
4.15. Firmware Upgrades .....	20
4.16. Reset, Powerup, and Powerdown .....	20
4.17. Programming with Commands .....	20
<b>5. Commands and Properties</b> .....	<b>21</b>
<b>6. Pin Descriptions: Si4730/31-GM</b> .....	<b>24</b>
<b>7. Ordering Guide</b> .....	<b>25</b>
<b>8. Package Markings (Top Marks)</b> .....	<b>26</b>
8.1. Si4730/31 Top Mark .....	26
8.2. Top Mark Explanation .....	26
<b>9. Package Outline: Si4730/31 QFN</b> .....	<b>27</b>
<b>10. PCB Land Pattern: Si4730/31 QFN</b> .....	<b>28</b>
<b>11. Additional Reference Resources</b> .....	<b>30</b>
<b>Document Change List</b> .....	<b>31</b>
<b>Contact Information</b> .....	<b>32</b>

# Si4730/31-A10

## 1. Electrical Specifications

Table 1. Recommended Operating Conditions

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Supply Voltage	$V_{DD}$		2.7	—	5.5	V
Interface Supply Voltage	$V_{IO}$		1.5	—	3.6	V
Power Supply Power-Up Rise Time	$V_{DDRISE}$		10	—	—	$\mu$ s
Interface Power Supply Power-Up Rise Time	$V_{IORISE}$		10	—	—	$\mu$ s
Ambient Temperature	$T_A$		-20	25	85	$^{\circ}$ C

**Note:** All minimum and maximum specifications are guaranteed and apply across the recommended operating conditions. Typical values apply at  $V_{DD} = 3.3$  V and  $25$   $^{\circ}$ C unless otherwise stated. Parameters are tested in production unless otherwise stated.

Table 2. Absolute Maximum Ratings<sup>1,2</sup>

Parameter	Symbol	Value	Unit
Supply Voltage	$V_{DD}$	-0.5 to 5.8	V
Interface Supply Voltage	$V_{IO}$	-0.5 to 3.9	V
Input Current <sup>3</sup>	$I_{IN}$	10	mA
Input Voltage <sup>3</sup>	$V_{IN}$	-0.3 to ( $V_{IO} + 0.3$ )	V
Operating Temperature	$T_{OP}$	-40 to 95	$^{\circ}$ C
Storage Temperature	$T_{STG}$	-55 to 150	$^{\circ}$ C
RF Input Level <sup>4</sup>		0.4	$V_{pK}$

**Notes:**

1. Permanent device damage may occur if the above Absolute Maximum Ratings are exceeded. Functional operation should be restricted to the conditions as specified in the operational sections of this data sheet. Exposure beyond recommended operating conditions for extended periods may affect device reliability.
2. The Si4730/31 devices are high-performance RF integrated circuits with certain pins having an ESD rating of < 2 kV HBM. Handling and assembly of these devices should only be done at ESD-protected workstations.
3. For input pins SCLK, SEN, SDIO, RST, RCLK, GPO1, GPO2, and GPO3.
4. At RF input pins, FMI and AMI.

**Table 3. DC Characteristics**(V<sub>DD</sub> = 2.7 to 5.5 V, V<sub>IO</sub> = 1.5 to 3.6 V, T<sub>A</sub> = -20 to 85 °C)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
<b>FM Mode</b>						
Supply Current	I <sub>FM</sub>		—	19.2	22	mA
Supply Current <sup>1</sup>	I <sub>FM</sub>	Low SNR level	—	19.8	23	mA
RDS Supply Current	I <sub>FM</sub>		—	19.9	23	mA
<b>AM Mode</b>						
Supply Current	I <sub>AM</sub>	Analog Output Mode	—	16.8	20.5	mA
<b>Supplies and Interface</b>						
Interface Supply Current	I <sub>IO</sub>		—	400	820	μA
Powerdown Current <sup>2</sup>	I <sub>DD</sub>		—	10	20	μA
Interface Powerdown Current <sup>2</sup>	I <sub>IO</sub>	SCLK, RCLK inactive	—	1	10	μA
High Level Input Voltage <sup>3</sup>	V <sub>IH</sub>		0.7 x V <sub>IO</sub>	—	—	V
Low Level Input Voltage <sup>3</sup>	V <sub>IL</sub>		—	—	0.3 x V <sub>IO</sub>	V
High Level Input Current <sup>3</sup>	I <sub>IH</sub>	V <sub>IN</sub> = V <sub>IO</sub> = 3.6 V	-10	—	10	μA
Low Level Input Current <sup>3</sup>	I <sub>IL</sub>	V <sub>IN</sub> = 0 V, V <sub>IO</sub> = 3.6 V	-10	—	10	μA
High Level Output Voltage <sup>4</sup>	V <sub>OH</sub>	I <sub>OUT</sub> = 500 μA	0.8 x V <sub>IO</sub>	—	—	V
Low Level Output Voltage <sup>4</sup>	V <sub>OL</sub>	I <sub>OUT</sub> = -500 μA	—	—	0.2 x V <sub>IO</sub>	V
<b>Notes:</b>						
1. LNA is automatically switched to higher current mode for optimum sensitivity in weak signal conditions.						
2. Specifications are guaranteed by characterization.						
3. For input pins SCLK, SEN, SDIO, RST, and RCLK.						
4. For output pins SDIO, GPO1, GPO2, and GPO3.						

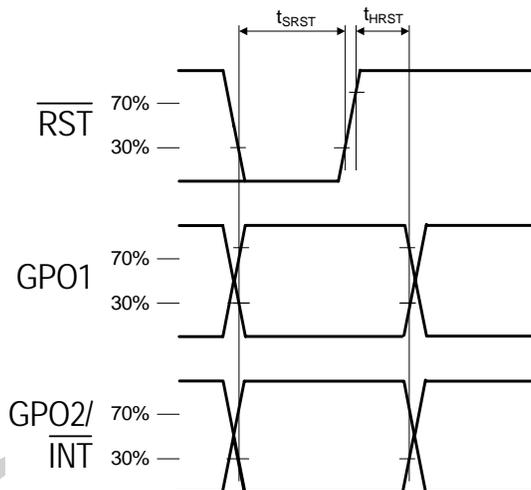
**Table 4. Reset Timing Characteristics<sup>1,2,3</sup>**

( $V_{DD} = 2.7$  to  $5.5$  V,  $V_{IO} = 1.5$  to  $3.6$  V,  $T_A = -20$  to  $85$  °C)

Parameter	Symbol	Min	Typ	Max	Unit
$\overline{RST}$ Pulse Width and GPO1, GPO2/ $\overline{INT}$ Setup to $\overline{RST}\uparrow^4$	$t_{SRST}$	100	—	—	$\mu$ s
GPO1, GPO2/ $\overline{INT}$ Hold from $\overline{RST}\uparrow$	$t_{HRST}$	30	—	—	ns

**Important Notes:**

1. When selecting 2-wire mode, the user must ensure that a 2-wire start condition (falling edge of SDIO while SCLK is high) does not occur within 300 ns before the rising edge of  $\overline{RST}$ .
2. When selecting 2-wire mode, the user must ensure that SCLK is high during the rising edge of  $\overline{RST}$ , and stays high until after the 1st start condition.
3. When selecting 3-wire or SPI modes, the user must ensure that a rising edge of SCLK does not occur within 300 ns before the rising edge of  $\overline{RST}$ .
4. If GPO1 and GPO2 are actively driven by the user, then minimum  $t_{SRST}$  is only 30 ns. If GPO1 or GPO2 is hi-Z, then minimum  $t_{SRST}$  is 100  $\mu$ s, to provide time for on-chip 1 M $\Omega$  devices (active while  $\overline{RST}$  is low) to pull GPO1 high and GPO2 low.



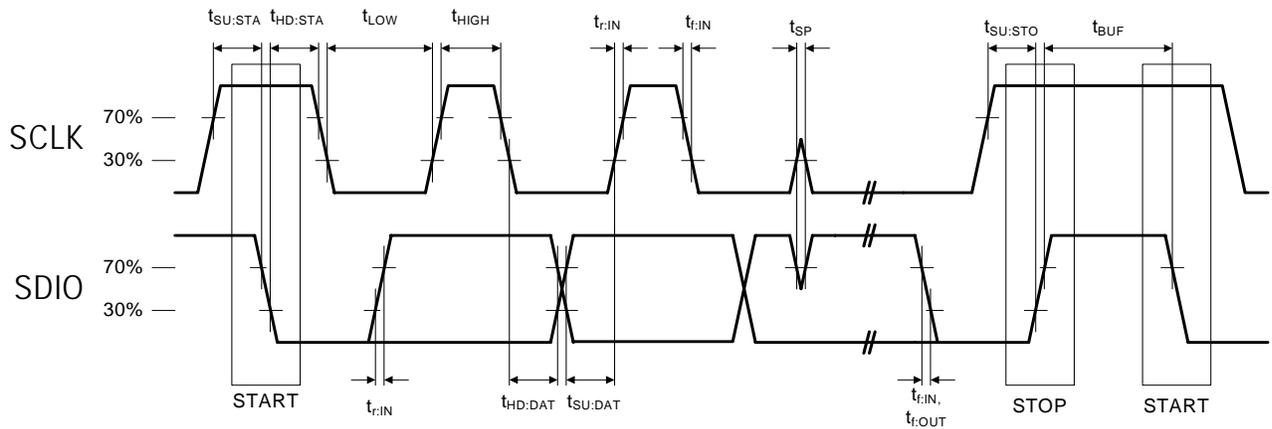
**Figure 1. Reset Timing Parameters for Busmode Select**

**Table 5. 2-Wire Control Interface Characteristics<sup>1,2,3</sup>**(V<sub>DD</sub> = 2.7 to 5.5 V, V<sub>IO</sub> = 1.5 to 3.6 V, T<sub>A</sub> = -20 to 85 °C)

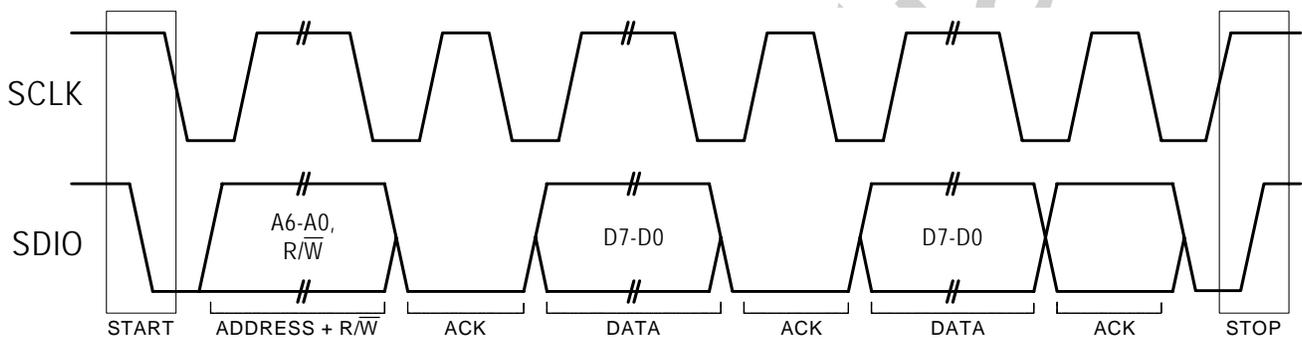
Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
SCLK Frequency	f <sub>SCL</sub>		0	—	400	kHz
SCLK Low Time	t <sub>LOW</sub>		1.3	—	—	μs
SCLK High Time	t <sub>HIGH</sub>		0.6	—	—	μs
SCLK Input to SDIO ↓ Setup (START)	t <sub>SU:STA</sub>		0.6	—	—	μs
SCLK Input to SDIO ↓ Hold (START)	t <sub>HD:STA</sub>		0.6	—	—	μs
SDIO Input to SCLK ↑ Setup	t <sub>SU:DAT</sub>		100	—	—	ns
SDIO Input to SCLK ↓ Hold <sup>4,5</sup>	t <sub>HD:DAT</sub>		0	—	900	ns
SCLK input to SDIO ↑ Setup (STOP)	t <sub>SU:STO</sub>		0.6	—	—	μs
STOP to START Time	t <sub>BUF</sub>		1.3	—	—	μs
SDIO Output Fall Time	t <sub>f:OUT</sub>		20 + 0.1 x C <sub>b</sub>	—	250	ns
SDIO Input, SCLK Rise/Fall Time	t <sub>f:IN</sub> t <sub>r:IN</sub>		20 + 0.1 x C <sub>b</sub>	—	300	ns
SCLK, SDIO Capacitive Loading	C <sub>b</sub>		—	—	50	pF
Input Filter Pulse Suppression	t <sub>SP</sub>		—	—	50	ns

**Notes:**

1. When V<sub>IO</sub> = 0 V, SCLK and SDIO are low impedance.
2. When selecting 2-wire mode, the user must ensure that a 2-wire start condition (falling edge of SDIO while SCLK is high) does not occur within 300 ns before the rising edge of  $\overline{RST}$ .
3. When selecting 2-wire mode, the user must ensure that SCLK is high during the rising edge of  $\overline{RST}$ , and stays high until after the 1st start condition.
4. The Si4730/31 delays SDIO by a minimum of 300 ns from the V<sub>IH</sub> threshold of SCLK to comply with the 0 ns t<sub>HD:DAT</sub> specification.
5. The maximum t<sub>HD:DAT</sub> has only to be met when f<sub>SCL</sub> = 400 kHz. At frequencies below 400 KHz, t<sub>HD:DAT</sub> may be violated so long as all other timing parameters are met.



**Figure 2. 2-Wire Control Interface Read and Write Timing Parameters**

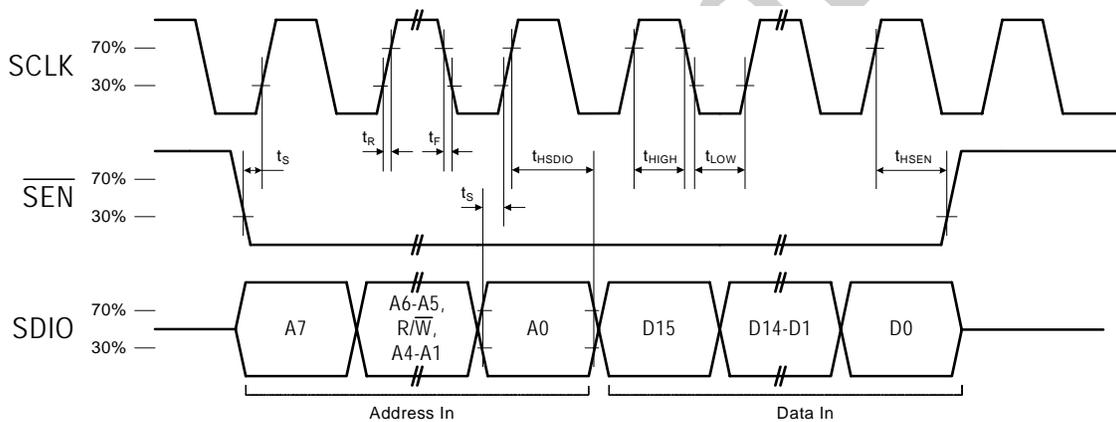
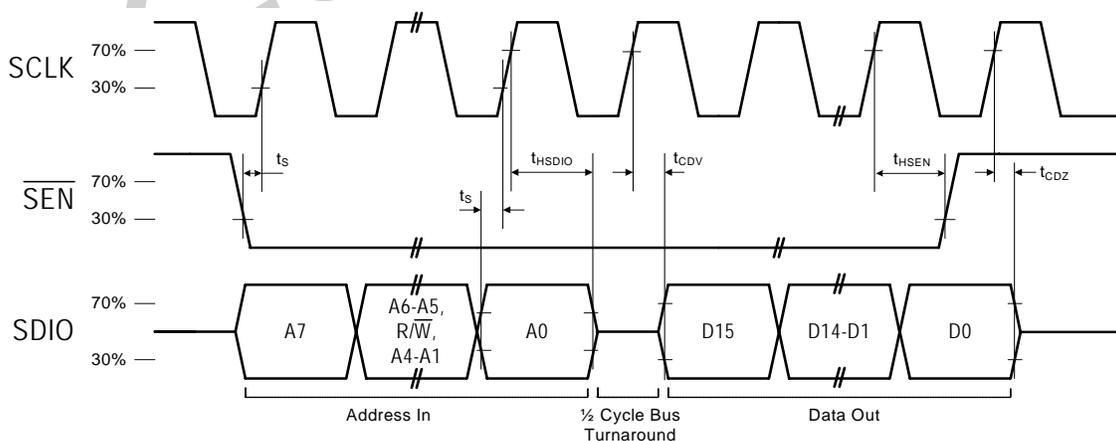


**Figure 3. 2-Wire Control Interface Read and Write Timing Diagram**

**Table 6. 3-Wire Control Interface Characteristics** $(V_{DD} = 2.7 \text{ to } 5.5 \text{ V}, V_{IO} = 1.5 \text{ to } 3.6 \text{ V}, T_A = -20 \text{ to } 85 \text{ }^\circ\text{C})$ 

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
SCLK Frequency	$f_{CLK}$		—	—	2.5	MHz
SCLK High Time	$t_{HIGH}$		25	—	—	ns
SCLK Low Time	$t_{LOW}$		25	—	—	ns
SDIO Input, $\overline{SEN}$ to SCLK $\uparrow$ Setup	$t_S$		20	—	—	ns
SDIO Input to SCLK $\uparrow$ Hold	$t_{HSDIO}$		10	—	—	ns
$\overline{SEN}$ Input to SCLK $\downarrow$ Hold	$t_{HSEN}$		10	—	—	ns
SCLK $\uparrow$ to SDIO Output Valid	$t_{CDV}$	Read	2	—	25	ns
SCLK $\uparrow$ to SDIO Output High Z	$t_{CDZ}$	Read	2	—	25	ns
SCLK, $\overline{SEN}$ , SDIO, Rise/Fall time	$t_R, t_F$		—	—	10	ns

**Note:** When selecting 3-wire mode, the user must ensure that a rising edge of SCLK does not occur within 300 ns before the rising edge of RST.

**Figure 4. 3-Wire Control Interface Write Timing Parameters****Figure 5. 3-Wire Control Interface Read Timing Parameters**

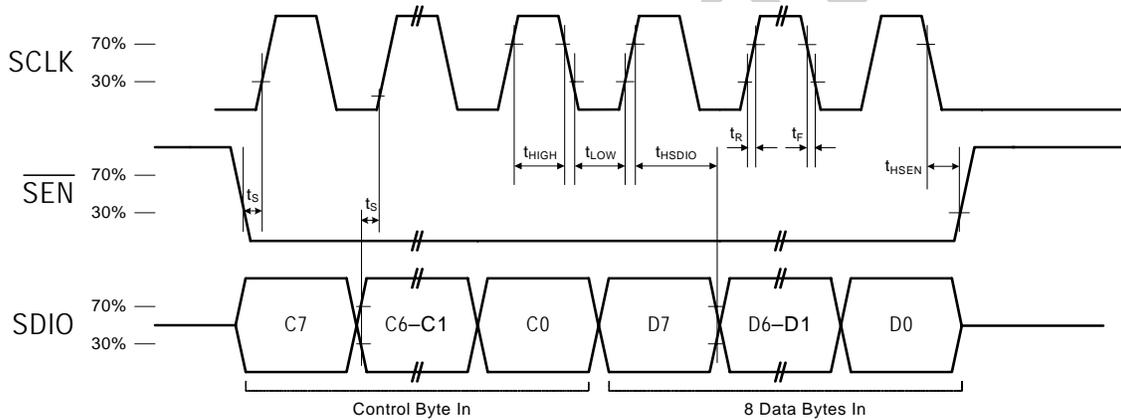
# Si4730/31-A10

**Table 7. SPI Control Interface Characteristics**

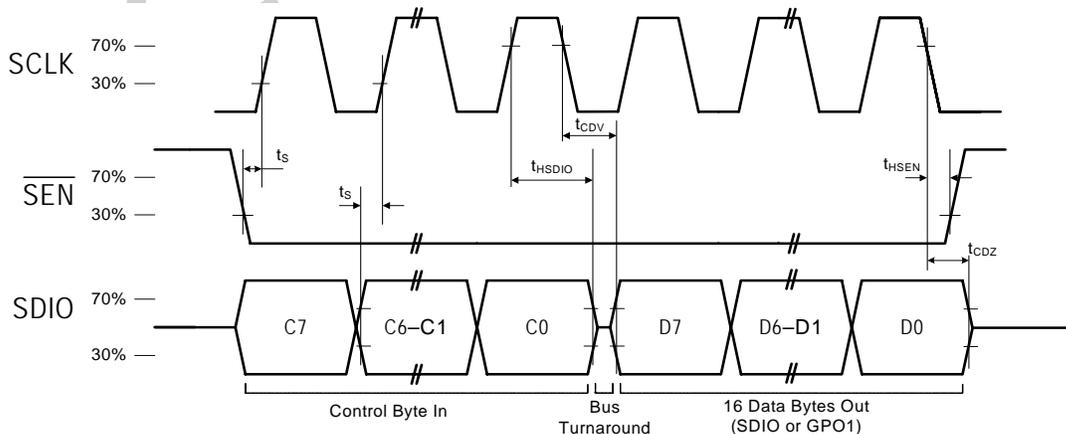
( $V_{DD} = 2.7$  to  $5.5$  V,  $V_{IO} = 1.5$  to  $3.6$  V,  $T_A = -20$  to  $85$  °C)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
SCLK Frequency	$f_{CLK}$		0	—	2.5	MHz
SCLK High Time	$t_{HIGH}$		25	—	—	ns
SCLK Low Time	$t_{LOW}$		25	—	—	ns
SDIO Input, $\overline{SEN}$ to SCLK $\uparrow$ Setup	$t_S$		15	—	—	ns
SDIO Input to SCLK $\uparrow$ Hold	$t_{HSDIO}$		10	—	—	ns
$\overline{SEN}$ Input to SCLK $\downarrow$ Hold	$t_{HSEN}$		5	—	—	ns
SCLK $\downarrow$ to SDIO Output Valid	$t_{CDV}$	Read	2	—	25	ns
SCLK $\downarrow$ to SDIO Output High Z	$t_{CDZ}$	Read	2	—	25	ns
SCLK, $\overline{SEN}$ , SDIO, Rise/Fall time	$t_R, t_F$		—	—	10	ns

**Note:** When selecting SPI mode, the user must ensure that a rising edge of SCLK does not occur within 300 ns before the rising edge of RST.



**Figure 6. SPI Control Interface Write Timing Parameters**



**Figure 7. SPI Control Interface Read Timing Parameters**

**Table 8. FM Receiver Characteristics<sup>1,2</sup>**(V<sub>DD</sub> = 2.7 to 5.5 V, V<sub>IO</sub> = 1.5 to 3.6 V, T<sub>A</sub> = -20 to 85 °C)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Input Frequency	f <sub>RF</sub>		76	—	108	MHz
Sensitivity with Headphone Network <sup>3,4,5</sup>		(S+N)/N = 26 dB	—	2.2	3.5	μV EMF
Sensitivity with 50 Ω Network <sup>3,4,5,7</sup>		(S+N)/N = 26 dB	—	1.1	—	μV EMF
RDS Sensitivity <sup>7</sup>		Δf = 2 kHz, RDS BLER < 5%	—	15	—	μV EMF
LNA Input Resistance <sup>6,7</sup>			3	4	5	kΩ
LNA Input Capacitance <sup>6,7</sup>			4	5	6	pF
Input IP <sub>3</sub> <sup>7,8</sup>			100	105	—	dBμV EMF
AM Suppression <sup>3,4,6,7</sup>		m = 0.3	40	50	—	dB
Adjacent Channel Selectivity		±200 kHz	35	50	—	dB
Alternate Channel Selectivity		±400 kHz	60	70	—	dB
Spurious Response Rejection <sup>7</sup>		In-band	35	—	—	dB
Audio Output Voltage <sup>3,4,6</sup>			72	80	90	mV <sub>RMS</sub>
Audio Output L/R Imbalance <sup>3,6,9</sup>			—	—	1	dB
Audio Band Limits <sup>3,6,7</sup>		±1.5 dB	30	—	15k	Hz
Audio Stereo Separation <sup>6,9</sup>			25	—	—	dB
Audio Mono S/N <sup>3,4,5,6</sup>			56	63	—	dB
Audio Stereo S/N <sup>5</sup>			—	58	—	dB
Audio THD <sup>3,6,9</sup>			—	0.1	0.5	%
De-emphasis Time Constant <sup>7</sup>		FM_DEEMPHASIS = 2	70	75	80	μs
		FM_DEEMPHASIS = 1	45	50	54	μs
Audio Common Mode Voltage <sup>10</sup>			0.7	0.8	0.9	V
Audio Output Load Resistance <sup>7,10</sup>	R <sub>L</sub>	Single-ended	10	—	—	kΩ
Audio Output Load Capacitance <sup>7,10</sup>	C <sub>L</sub>	Single-ended	—	—	50	pF

**Notes:**

1. Additional testing information is available in Application Note AN234. Volume = maximum for all tests. Tested at R<sub>f</sub> = 100 MHz.
2. To ensure proper operation and receiver performance, follow the guidelines in "AN384: Si4730/31 AM/FM Receiver Layout Guide." Silicon Laboratories will evaluate schematics and layouts for qualified customers.
3. F<sub>MOD</sub> = 1 kHz, 75 μs de-emphasis, MONO = enabled, and L = R unless noted otherwise.
4. Δf = 22.5 kHz.
5. B<sub>AF</sub> = 300 Hz to 15 kHz, A-weighted.
6. V<sub>EMF</sub> = 1 mV.
7. Guaranteed by characterization.
8. |f<sub>2</sub> - f<sub>1</sub>| > 2 MHz, f<sub>0</sub> = 2 x f<sub>1</sub> - f<sub>2</sub>. AGC is disabled. Refer to "6. Pin Descriptions: Si4730/31-GM" on page 24.
9. Δf = 75 kHz.
10. At LOUT and ROUT pins.

# Si4730/31-A10

**Table 8. FM Receiver Characteristics<sup>1,2</sup> (Continued)**

( $V_{DD} = 2.7$  to  $5.5$  V,  $V_{IO} = 1.5$  to  $3.6$  V,  $T_A = -20$  to  $85$  °C)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Seek/Tune Time <sup>7</sup>			—	—	80	ms/channel
Powerup Time <sup>7</sup>		From powerdown	—	—	110	ms
RSSI Offset		Input levels of 8 and 60 dB $\mu$ V EMF	-3	—	3	dB

**Notes:**

1. Additional testing information is available in Application Note AN234. Volume = maximum for all tests. Tested at  $f_r = 100$  MHz.
2. To ensure proper operation and receiver performance, follow the guidelines in "AN384: Si4730/31 AM/FM Receiver Layout Guide." Silicon Laboratories will evaluate schematics and layouts for qualified customers.
3.  $F_{MOD} = 1$  kHz, 75  $\mu$ s de-emphasis, MONO = enabled, and L = R unless noted otherwise.
4.  $\Delta f = 22.5$  kHz.
5.  $B_{AF} = 300$  Hz to 15 kHz, A-weighted.
6.  $V_{EMF} = 1$  mV.
7. Guaranteed by characterization.
8.  $|f_2 - f_1| > 2$  MHz,  $f_0 = 2 \times f_1 - f_2$ . AGC is disabled. Refer to "6. Pin Descriptions: Si4730/31-GM" on page 24.
9.  $\Delta f = 75$  kHz.
10. At LOUT and ROUT pins.

**Table 9. AM Receiver Characteristics<sup>1</sup>**

( $V_{DD} = 2.7$  to  $5.5$  V,  $V_{IO} = 1.5$  to  $3.6$  V,  $T_A = -20$  to  $85$  °C)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Input Frequency	$f_{RF}$		520	—	1710	kHz
Sensitivity <sup>2,3</sup>		(S+N)/N = 26 dB	—	38	—	$\mu$ V EMF
Large Signal Voltage Handling <sup>4</sup>		THD < 8%	—	300	—	mV <sub>RMS</sub>
Power Supply Rejection Ratio		$\Delta V_{DD} = 100$ mV <sub>RMS</sub> , 100 Hz	—	40	—	dB
Audio Output Voltage <sup>2,5</sup>			54	60	67	mV <sub>RMS</sub>
Audio S/N <sup>2,3,5</sup>			48	56	—	dB
Audio THD <sup>2,3,5</sup>			—	0.1	0.5	%
Antenna Inductance <sup>4</sup>			180	—	600	$\mu$ H
Powerup Time		From powerdown	—	—	110	ms

**Notes:**

1. To ensure proper operation and receiver performance, follow the guidelines in "AN384: Si4730/31 AM/FM Receiver Layout Guide." Silicon Laboratories will evaluate schematics and layouts for qualified customers.
2.  $F_{MOD} = 1$  kHz, 30% modulation, A-weighted, 2 kHz channel filter.
3.  $f_{RF} = 1000$  kHz,  $\Delta f = 10$  kHz.
4. Guaranteed by characterization.
5.  $V_{IN} = 5$  mV<sub>rms</sub>.

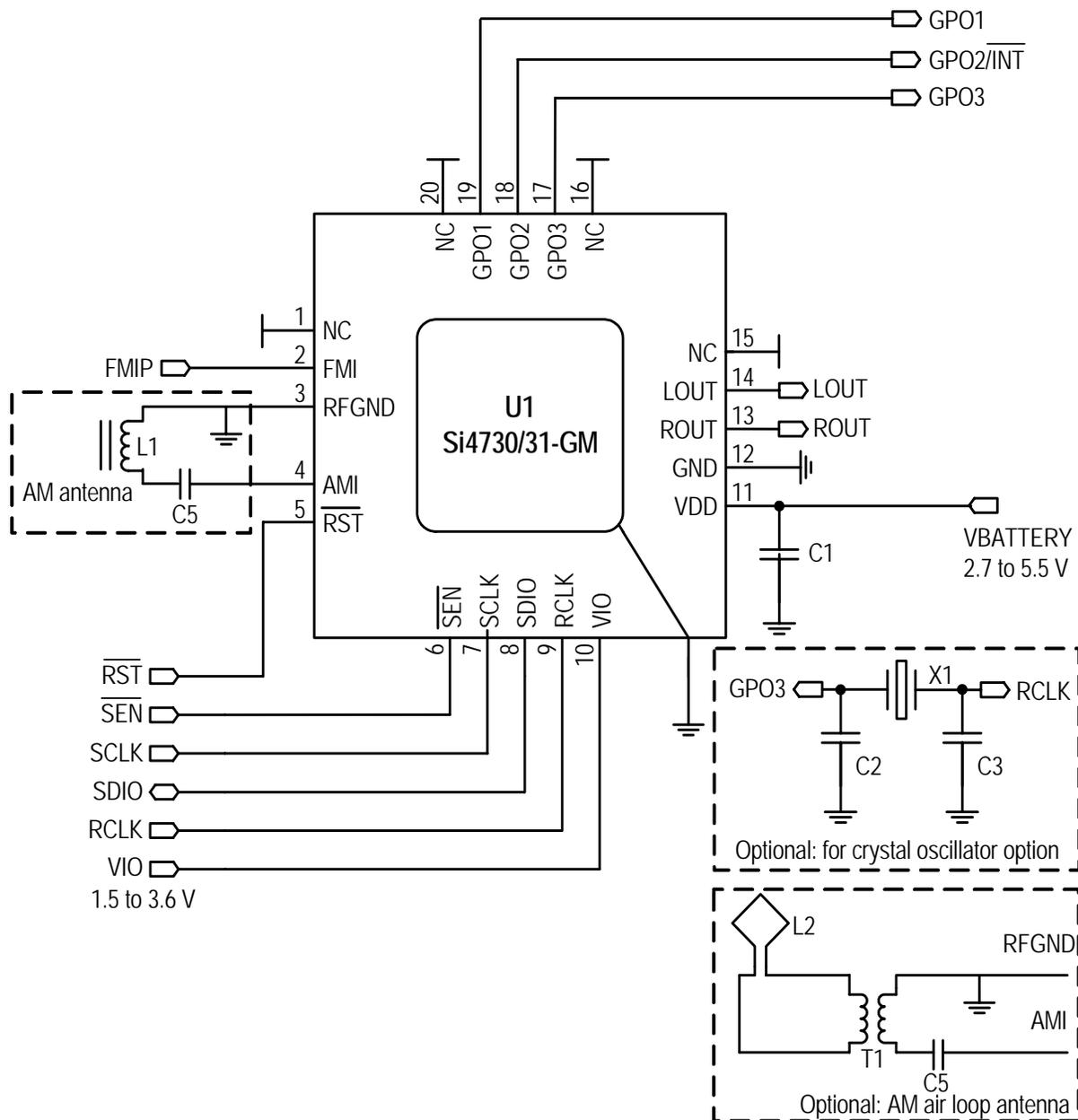
**Table 10. Reference Clock and Crystal Characteristics**(V<sub>DD</sub> = 2.7 to 5.5 V, V<sub>IO</sub> = 1.5 to 3.6 V, T<sub>A</sub> = -20 to 85 °C)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
<b>Reference Clock</b>						
RCLK Supported Frequency <sup>1</sup>			31.130	32.768	40,000	kHz
RCLK Frequency Tolerance <sup>2</sup>			-100	—	100	ppm
REFCLK_PRESCALE			1	—	4095	
REFCLK			31.130	32,768	34.406	kHz
<b>Crystal Oscillator</b>						
Crystal Oscillator Frequency			—	32.768	—	kHz
Crystal Frequency Tolerance <sup>2</sup>			-100	—	100	ppm
Board Capacitance			—	—	3.5	pF
<b>Notes:</b>						
1. The Si4730/31 divides the RCLK input by REFCLK_PRESCALE to obtain REFCLK. There are some RCLK frequencies between 31.130 kHz and 40 MHz that are not supported. See AN385, Table 6 for more details.						
2. A frequency tolerance of ±50 ppm is required for FM seek/tune using 50 kHz channel spacing.						

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# Si4730/31-A10

## 2. Typical Application Schematic



### Notes:

1. Place C1 close to V<sub>DD</sub> pin.
2. All grounds connect directly to GND plane on PCB.
3. Pins 1 and 20 are no connects, leave floating.
4. To ensure proper operation and receiver performance, follow the guidelines in "AN384: Si4730/31 AM/FM Receiver Layout Guide." Silicon Laboratories will evaluate schematics and layouts for qualified customers.
5. Pin 2 connects to the FM antenna interface, and pin 4 connects to the AM antenna interface.
6. RFGND should be locally isolated from GND.
7. Place Si4730/31 as close as possible to antenna jack and keep the FMI and AMI traces as short as possible.

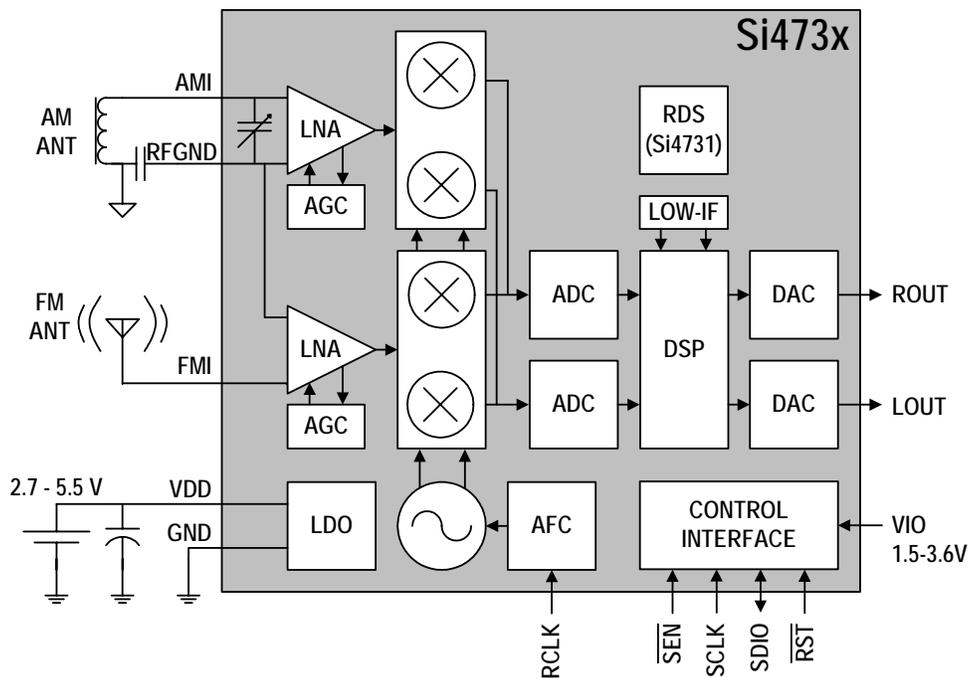
### 3. Bill of Materials

Component(s)	Value/Description	Supplier
C1	Supply bypass capacitor, 22 nF, $\pm 20\%$ , Z5U/X7R	Murata
C5	Coupling capacitor, 0.47 $\mu$ F, $\pm 20\%$ , Z5U/X7R	Murata
L1	Ferrite loop stick, 180–600 $\mu$ H	Various
U1	Si4730/31 AM/FM Radio Tuner	Silicon Laboratories
<b>Optional Components</b>		
T1	Transformer, 1–5 turns ratio	Various
L2	Air loop antenna, 10–20 $\mu$ H	Various
C2, C3	Crystal load capacitors, 22 pF, $\pm 5\%$ , COG (Optional: for crystal oscillator option)	Venkel
X1	32.768 kHz crystal (Optional: for crystal oscillator option)	Epson

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## 4. Functional Description

### 4.1. Overview



**Figure 8. Functional Block Diagram**

The Si4730/31 is the industry's first fully integrated, 100% CMOS AM/FM radio receiver IC. Offering unmatched integration and PCB space savings, the Si4730/31 requires only two external components and less than 15 mm<sup>2</sup> of board area, excluding the antenna inputs. The Si4730/31 AM/FM radio provides the space savings and low power consumption necessary for portable devices while delivering the high performance and design simplicity desired for all AM/FM solutions.

Leveraging Silicon Laboratories' proven and patented Si4700/01 FM tuner's digital low intermediate frequency (low-IF) receiver architecture, the Si4730/31 delivers superior RF performance and interference rejection in both AM and FM bands. The high integration and complete system production test simplifies design-in, increases system quality, and improves manufacturability.

The Si4730/31 is a feature-rich solution including advanced seek algorithms, soft mute, auto-calibrated digital tuning, and FM stereo processing. In addition, the Si4730/31 provides a programmable reference clock. The device supports I<sup>2</sup>C-compatible 2-wire control interface, SPI, and a Si4700/01 backwards-compatible 3-wire control interface.

The Si4730/31 utilizes digital processing to achieve high fidelity, optimal performance, and design flexibility. The chip provides excellent pilot rejection, selectivity, and unmatched audio performance, and offers both the manufacturer and the end-user extensive programmability and flexibility in listening experience.

The Si4731 incorporates a digital processor for the European Radio Data System (RDS) and the North American Radio Broadcast Data System (RBDS) including all required symbol decoding, block synchronization, error detection, and error correction functions. Using this feature, the Si4731 enables broadcast data such as station identification and song name to be displayed to the user.

### 4.2. Operating Modes

The Si4730/31 operates in either an FM receive or an AM receive mode. In FM mode, radio signals are received on FMI (pin 2) and processed by the FM front-end circuitry. In AM mode, radio signals are received on AMI (pin 4) and processed by the AM front-end circuitry. In addition to the receiver mode, there is a clocking mode to choose to clock the Si4730/31 from a reference clock or crystal. The receiver mode and the clocking mode are set by the POWER\_UP command listed in Table 12. Si473x Command Summary.

### 4.3. FM Receiver

The Si4730/31 FM receiver is based on the proven Si4700/01 FM tuner. The receiver uses a digital low-IF architecture allowing the elimination of external components and factory adjustments. The Si4730/31 integrates a low noise amplifier (LNA) supporting the worldwide FM broadcast band (76 to 108 MHz). An automatic gain control (AGC) circuit controls the gain of the LNA to optimize sensitivity and rejection of strong interferers. For testing purposes, the AGC can be disabled. Refer to Section "5. Commands and Properties" on page 21 for additional programming and configuration information. An image-reject mixer downconverts the RF signal to low-IF. The quadrature mixer output is amplified, filtered, and digitized with high resolution analog-to-digital converters (ADCs). This advanced architecture allows the Si4730/31 to perform channel selection, FM demodulation, and stereo audio processing to achieve superior performance compared to traditional analog architectures.

### 4.4. AM receiver

The highly integrated Si4730/31 supports worldwide AM band reception from 520 to 1710 kHz using a digital low-IF architecture with a minimum number of external components and no manual alignment required. This digital low-IF architecture allows for high-precision filtering offering excellent selectivity and noise suppression. The DSP also provides 9 or 10 kHz channel selection, AM demodulation, soft mute, and additional features such as adjustable channel bandwidth settings. Similar to the FM receiver, the integrated LNA and AGC optimize sensitivity and rejection of strong interferers allowing better reception of weak stations.

The Si4730/31 provides highly accurate digital AM tuning without factory adjustments. To offer maximum flexibility, the receiver supports a wide range of ferrite loop sticks from 180–600  $\mu\text{H}$ . An air loop antenna is supported by using a transformer to increase the effective inductance from the air loop. Using a 1:5 turn ratio inductor the inductance is increased by 25x easily supporting all typical AM air loop antennas which generally vary between 10 and 20  $\mu\text{H}$ .

### 4.5. Stereo Audio Processing

The output of the FM demodulator is a stereo multiplexed (MPX) signal. The MPX standard was developed in 1961, and is used worldwide. Today's MPX signal format consists of left + right (L+R) audio, left – right (L–R) audio, a 19 kHz pilot tone, and RDS/RBDS data as shown in Figure 9 below.

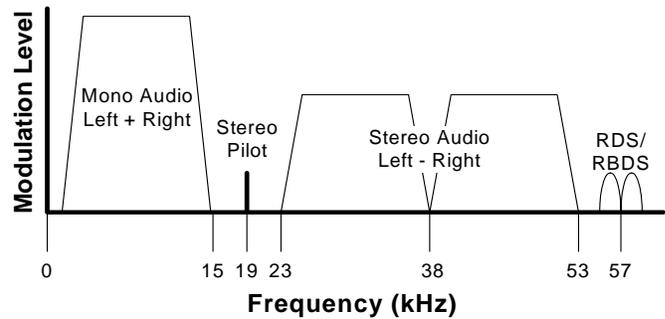


Figure 9. MPX Signal Spectrum

#### 4.5.1. Stereo Decoder

The Si4730/31's integrated stereo decoder automatically decodes the MPX signal using DSP techniques. The 0 to 15 kHz (L+R) signal is the mono output of the FM tuner. Stereo is generated from the (L+R), (L–R), and a 19 kHz pilot tone. The pilot tone is used as a reference to recover the (L–R) signal. Output left and right channels are obtained by adding and subtracting the (L+R) and (L–R) signals respectively. The Si4731 uses frequency information from the 19 kHz stereo pilot to recover the 57 kHz RDS/RBDS signal.

#### 4.5.2. Stereo-Mono Blending

Adaptive noise suppression is employed to gradually combine the stereo left and right audio channels to a mono (L+R) audio signal as the signal quality degrades to maintain optimum sound fidelity under varying reception conditions. Stereo/mono status can be monitored with the FM\_RSQ\_STATUS command. Mono operation can be forced with the FM\_BLEND\_MONO\_THRESHOLD property.

### 4.6. De-emphasis

Pre-emphasis and de-emphasis is a technique used by FM broadcasters to improve the signal-to-noise ratio of FM receivers by reducing the effects of high-frequency interference and noise. When the FM signal is transmitted, a pre-emphasis filter is applied to accentuate the high audio frequencies. The Si4730/31 incorporates a de-emphasis filter which attenuates high frequencies to restore a flat frequency response. Two time constants are used in various regions. The de-emphasis time constant is programmable to 50 or 75  $\mu\text{s}$  and is set by the FM\_DEEMPHASIS property.

### 4.7. Stereo DAC

High-fidelity stereo digital-to-analog converters (DACs) drive analog audio signals onto the LOUT and ROUT pins. The audio output may be muted. Volume is adjusted digitally with the RX\_VOLUME property.

## 4.8. Soft Mute

The soft mute feature is available to attenuate the audio outputs and minimize audible noise in very weak signal conditions. The softmute attenuation level is adjustable using the FM\_SOFT\_MUTE\_MAX\_ATTENUATION and AM\_SOFT\_MUTE\_MAX\_ATTENUATION properties.

## 4.9. RDS/RBDS Processor (Si4731 Only)

The Si4731 implements an RDS/RBDS\* processor for symbol decoding, block synchronization, error detection, and error correction.

The Si4731 device is user configurable and provides an optional interrupt when RDS is synchronized, loses synchronization, and/or the user configurable RDS FIFO threshold has been met.

The Si4731 reports RDS decoder synchronization status, and detailed bit errors in the information word for each RDS block with the FM\_RDS\_STATUS command. The range of reportable block errors is 0, 1–2, 3–5, or 6+. More than six errors indicates that the corresponding block information word contains six or more non-correctable errors, or that the block checkword contains errors.

**\*Note:** RDS/RBDS is referred to only as RDS throughout the remainder of this document.

## 4.10. Tuning

The frequency synthesizer uses Silicon Laboratories' proven technology, including a completely integrated VCO. The frequency synthesizer generates the quadrature local oscillator signal used to downconvert the RF input to a low intermediate frequency. The VCO frequency is locked to the reference clock and adjusted with an automatic frequency control (AFC) servo loop during reception. The tuning frequency can be directly programmed using the FM\_TUNE\_FREQ and AM\_TUNE\_FREQ commands. The Si4730/31 supports channel spacing of 50, 100, or 200 kHz in FM mode and 9 or 10 kHz in AM mode.

## 4.11. Seek

Seek tuning will search up or down for a valid channel. Valid channels are found when the receive signal strength indicator (RSSI) and the signal-to-noise ratio (SNR) values exceed the set threshold. Using the SNR qualifier rather than solely relying on the more traditional RSSI qualifier can reduce false stops and increase the number of valid stations detected. Seek is initiated using the FM\_SEEK\_START and AM\_SEEK\_START commands. The RSSI and SNR threshold settings are adjustable using properties (see Table 13).

Two seek options are available. The device will either wrap or stop at the band limits. If the seek operation is unable to find a channel, the device will indicate failure and return to the channel selected before the seek operation began.

## 4.12. Reference Clock

The Si4730/31 reference clock is programmable, supporting RCLK frequencies in Table 10. Refer to Table 3, "DC Characteristics," on page 5 for switching voltage levels and Table 8, "FM Receiver Characteristics" on page 11 for frequency tolerance information.

An onboard crystal oscillator is available to generate the 32.768 kHz reference when an external crystal and load capacitors are provided. Refer to "2. Typical Application Schematic" on page 14. This mode is enabled using the POWER\_UP command, see Table 12, "Si473x Command Summary," on page 21.

The Si4730/31 performance may be affected by data activity on the SDIO bus when using the integrated internal oscillator. SDIO activity results from polling the tuner for status or communicating with other devices that share the SDIO bus. If there is SDIO bus activity while the Si4730/31 is performing the seek/tune function, the crystal oscillator may experience jitter, which may result in mistunes, false stops, and/or lower SNR.

For best seek/tune results, Silicon Laboratories recommends that all SDIO data traffic be suspended during Si4730/31 seek and tune operations. This is achieved by keeping the bus quiet for all other devices on the bus, and delaying tuner polling until the tune or seek operation is complete. The STC (seek/tune complete) interrupt should be used instead of polling to determine when a seek/tune operation is complete.

## 4.13. Control Interface

A serial port slave interface is provided, which allows an external controller to send commands to the Si4730/31, and receive responses from the device. The serial port can operate in three bus modes: 2-wire mode, 3-wire mode, or SPI mode. The Si4730/31 selects the bus mode by sampling the state of the GPO1 and GPO2 pins on the rising edge of  $\overline{RST}$ . The GPO1 pin includes an internal pull-up resistor which is connected while  $\overline{RST}$  is low, and the GPO2 pin includes an internal pull-down resistor which is connected while  $\overline{RST}$  is low. Therefore, it is only necessary for the user to actively drive pins which differ from these states. See Table 11.

**Table 11. Bus Mode Select on Rising Edge of RST**

Bus Mode	GPO1	GPO2
2-Wire	1	0
SPI	1	1 (must drive)
3-Wire	0 (must drive)	0

After the rising edge of  $\overline{\text{RST}}$ , the pins GPO1 and GPO2 are used as general purpose output (O) pins as described in Section “4.14. GPO Outputs”. In any bus mode, commands may only be sent after VIO and VDD supplies are applied.

In any bus mode, before sending a command or reading a response, the user must first read the status byte to ensure that the device is ready (CTS bit is high).

#### 4.13.1. 2-Wire Control Interface Mode

When selecting 2-wire mode, the user must ensure that SCLK is high during the rising edge of  $\overline{\text{RST}}$ , and stays high until after the first start condition. Also, a start condition must not occur within 300 ns before the rising edge of  $\overline{\text{RST}}$ .

2-wire bus mode uses only the SCLK and SDIO pins for signaling. A transaction begins with the START condition, which occurs when SDIO falls while SCLK is high. Next, the user drives an 8-bit control word serially on SDIO, which is captured by the device on rising edges of SCLK. The control word consists of a seven bit device address, followed by a read/write bit (read = 1, write = 0). The Si4730/31 acknowledges the control word by driving SDIO low on the next falling edge of SCLK.

Although the Si4730/31 will respond to only a single device address, this address can be changed with the  $\overline{\text{SEN}}$  pin (note that the  $\overline{\text{SEN}}$  pin is not used for signaling in 2-wire mode). When  $\overline{\text{SEN}} = 0$ , the seven-bit device address is 0010001b. When  $\overline{\text{SEN}} = 1$ , the address is 1100011b.

For write operations, the user then sends an eight bit data byte on SDIO, which is captured by the device on rising edges of SCLK. The Si4730/31 acknowledges each data byte by driving SDIO low for one cycle, on the next falling edge of SCLK. The user may write up to 8 data bytes in a single 2-wire transaction. The first byte is a command, and the next seven bytes are arguments.

For read operations, after the Si4730/31 has acknowledged the control byte, it will drive an eight bit data byte on SDIO, changing the state of SDIO on the falling edge of SCLK. The user acknowledges each data byte by driving SDIO low for one cycle, on the next falling edge of SCLK. If a data byte is not

acknowledged, the transaction will end. The user may read up to 16 data bytes in a single 2-wire transaction. These bytes contain the response data from the Si4730/31.

A 2-wire transaction ends with the STOP condition, which occurs when SDIO rises while SCLK is high.

For details on timing specifications and diagrams, refer to Table 5, “2-Wire Control Interface Characteristics” on page 7, Figure 2, “2-Wire Control Interface Read and Write Timing Parameters,” on page 8 and Figure 3, “2-Wire Control Interface Read and Write Timing Diagram,” on page 8.

#### 4.13.2. 3-Wire Control Interface Mode

When selecting 3-wire mode, the user must ensure that a rising edge of SCLK does not occur within 300 ns before the rising edge of  $\overline{\text{RST}}$ .

3-wire bus mode uses the SCLK, SDIO and  $\overline{\text{SEN}}$  pins. A transaction begins when the user drives  $\overline{\text{SEN}}$  low. Next, the user drives a 9-bit control word on SDIO, which is captured by the device on rising edges of SCLK. The control word consists of a three-bit device address (A7:A5 = 101b), a read/write bit (read = 1, write = 0), and a five-bit register address (A4:A0).

For write operations, the control word is followed by a 16-bit data word, which is captured by the device on rising edges of SCLK.

For read operations, the control word is followed by a delay of one-half SCLK cycle for bus turn-around. Next, the Si4730/31 will drive the 16-bit read data word serially on SDIO, changing the state of SDIO on each rising edge of SCLK.

A transaction ends when the user sets  $\overline{\text{SEN}}$  high, then pulses SCLK high and low one final time. SCLK may either stop or continue to toggle while  $\overline{\text{SEN}}$  is high.

In 3-wire mode, commands are sent by first writing each argument to register(s) 0xA1–0xA3, then writing the command word to register 0xA0. A response is retrieved by reading registers 0xA8–0xAF.

For details on timing specifications and diagrams, refer to Table 6, “3-Wire Control Interface Characteristics,” on page 9, Figure 4, “3-Wire Control Interface Write Timing Parameters,” on page 9, and Figure 5, “3-Wire Control Interface Read Timing Parameters,” on page 9.

#### 4.13.3. SPI Control Interface Mode

When selecting SPI mode, the user must ensure that a rising edge of SCLK does not occur within 300 ns before the rising edge of  $\overline{\text{RST}}$ .

SPI bus mode uses the SCLK, SDIO and  $\overline{\text{SEN}}$  pins for read/write operations. The system controller can choose to receive read data from the device on either

SDIO or GPO1. A transaction begins when the system controller drives  $\overline{\text{SEN}} = 0$ . The system controller then pulses SCLK eight times, while driving an 8-bit control byte serially on SDIO. The device captures the data on rising edges of SCLK. The control byte must have one of five values:

- 0x48 = write a command (controller drives 8 additional bytes on SDIO).
- 0x80 = read a response (device drives one additional byte on SDIO).
- 0xC0 = read a response (device drives 16 additional bytes on SDIO).
- 0xA0 = read a response (device drives one additional byte on GPO1).
- 0xE0 = read a response device drives 16 additional bytes on GPO1).

For write operations, the system controller must drive exactly 8 data bytes (a command and seven arguments) on SDIO after the control byte. The data is captured by the device on the rising edge of SCLK.

For read operations, the controller must read exactly one byte (STATUS) after the control byte or exactly 16 data bytes (STATUS and RESP1–RESP15) after the control byte. The device changes the state of SDIO (or GPO1, if specified) on the falling edge of SCLK. Data must be captured by the system controller on the rising edge of SCLK.

Keep  $\overline{\text{SEN}}$  low until all bytes have transferred. A transaction may be aborted at any time by setting  $\overline{\text{SEN}}$  high and toggling SCLK high and then low. Commands will be ignored by the device if the transaction is aborted.

For details on timing specifications and diagrams, refer to Figure 6 and Figure 7 on page 10.

## 4.14. GPO Outputs

GPO2 can be configured to provide interrupts for seek and tune complete, receive signal quality, and RDS. GPO1 and GPO3 are not available on Si4730-A10 and Si4731-A10.

## 4.15. Firmware Upgrades

The Si4730/31 contains on-chip program RAM to accommodate minor changes to the firmware. This allows Silicon Labs to provide future firmware updates to optimize the characteristics of new radio designs and those already deployed in the field.

## 4.16. Reset, Powerup, and Powerdown

Setting the RST pin low will disable analog and digital circuitry, reset the registers to their default settings, and disable the bus. Setting the RST pin high will bring the device out of reset.

A powerdown mode is available to reduce power consumption when the part is idle. Putting the device in powerdown mode will disable analog and digital circuitry while keeping the bus active.

## 4.17. Programming with Commands

To ease development time and offer maximum customization, the Si4730/31 provides a simple yet powerful software interface to program the receiver. The device is programmed using commands, arguments, properties and responses.

To perform an action, the user writes a command byte and associated arguments causing the chip to execute the given command. Commands control an action such as power up the device, shut down the device, or tune to a station. Arguments are specific to a given command and are used to modify the command. A complete list of commands is available in Table 12, “Si473x Command Summary,” on page 21.

Properties are a special command argument used to modify the default chip operation and are generally configured immediately after power-up. Examples of properties are de-emphasis level, RSSI seek threshold, and soft mute attenuation threshold. A complete list of properties is available in Table 13, “Si473x Property Summary,” on page 21.

Responses provide the user information and are echoed after a command and associated arguments are issued. All commands provide a one-byte status update indicating interrupt and clear-to-send status information. For a detailed description of the commands and properties for the Si4730/31, see “AN385: Si4730/31 AM/FM Receiver Programming Guide.”

## 5. Commands and Properties

**Table 12. Si473x Command Summary**

Cmd	Name	Description
0x01	POWER_UP	Power up device and mode selection. Modes include AM or FM receive and reference clock or crystal support.
0x10	GET_REV	Returns revision information on the device.
0x11	POWER_DOWN	Power down device.
0x12	SET_PROPERTY	Sets the value of a property.
0x13	GET_PROPERTY	Retrieves a property's value.
0x14	GET_INT_STATUS	Read interrupt status bits.
0x15	PATCH_ARGS	Reserved command used for firmware file downloads.
0x16	PATCH_DATA	Reserved command used for firmware file downloads.
0x20	FM_TUNE_FREQ	Selects the FM tuning frequency.
0x21	FM_SEEK_START	Begins searching for a valid frequency
0x22	FM_TUNE_STATUS	Queries the status of previous FM_TUNE_FREQ or FM_SEEK_START command.
0x23	FM_RSQ_STATUS	Queries the status of the Received Signal Quality (RSQ) of the current channel.
0x24	FM_RDS_STATUS	Returns RDS information for current channel and reads an entry from the RDS FIFO (Si4731 only).
0x40	AM_TUNE_FREQ	Tunes to a given AM frequency.
0x41	AM_SEEK_START	Begins searching for a valid frequency.
0x42	AM_TUNE_STATUS	Queries the status of the already issued AM_TUNE_FREQ or AM_SEEK_START command.
0x43	AM_RSQ_STATUS	Queries the status of the Received Signal Quality (RSQ) for the current channel.

**Table 13. Si473x Property Summary**

Prop	Name	Description	Default
0x0001	GPO_IEN	Enables interrupt sources.	0x0000
0x0201	REFCLK_FREQ	Sets frequency of reference clock in Hz. The range is 31130 to 34406 Hz, or 0 to disable the AFC. Default is 32768 Hz.	0x8000
0x0202	REFCLK_PRESCALE	Sets the prescaler value for RCLK input.	0x0001
0x1100	FM_DEEMPHASIS	Sets deemphasis time constant. Default is 75 us.	0x0002
0x1105	FM_BLEND_STEREO_THRESHOLD	Sets RSSI threshold for stereo blend (Full stereo above threshold, blend below threshold). To force stereo set this to 0. To force mono set this to 127. Default value is 49 dBuV.	0x0031
0x1106	FM_BLEND_MONO_THRESHOLD	Sets RSSI threshold for mono blend (Full mono below threshold, blend above threshold). To force stereo set this to 0. To force mono set this to 127. Default value is 30 dBuV.	0x001E
0x1108	FM_MAX_TUNE_ERROR	Sets the maximum freq error allowed before setting the AFC rail (AFCRL) indicator. Default value is 30 kHz.	0x001E
0x1200	FM_RSQ_INT_SOURCE	Configures interrupt related to Received Signal Quality metrics.	0x0000

**Table 13. Si473x Property Summary (Continued)**

Prop	Name	Description	Default
0x1201	FM_RSQ_SNR_HI_THRESHOLD	Sets high threshold for SNR interrupt.	0x007F
0x1202	FM_RSQ_SNR_LO_THRESHOLD	Sets low threshold for SNR interrupt.	0x0000
0x1203	FM_RSQ_RSSI_HI_THRESHOLD	Sets high threshold for RSSI interrupt.	0x007F
0x1204	FM_RSQ_RSSI_LO_THRESHOLD	Sets low threshold for RSSI interrupt.	0x0000
0x1207	FM_RSQ_BLEND_THRESHOLD	Sets the blend threshold for blend interrupt when boundary is crossed.	0x0081
0x1300	FM_SOFT_MUTE_RATE	Sets the attack and decay rates when entering and leaving soft mute.	0x0040
0x1302	FM_SOFT_MUTE_MAX_ATTENUATION	Sets maximum attenuation during soft mute (dB). Set to 0 to disable soft mute. Default is 16 dB.	0x0010
0x1303	FM_SOFT_MUTE_SNR_THRESHOLD	Sets SNR threshold to engage soft mute. Default is 4 dB.	0x0004
0x1400	FM_SEEK_BAND_BOTTOM	Sets the bottom of the FM band for seek. Default is 8750.	0x222E
0x1401	FM_SEEK_BAND_TOP	Sets the top of the FM band for seek. Default is 10790.	0x2A26
0x1402	FM_SEEK_FREQ_SPACING	Selects frequency spacing for FM seek.	0x000A
0x1403	FM_SEEK_TUNE_SNR_THRESHOLD	Sets the SNR threshold for a valid FM Seek/Tune. Default value is 3 dB.	0x0003
0x1404	FM_SEEK_TUNE_RSSI_THRESHOLD	Sets the RSSI threshold for a valid FM Seek/Tune. Default value is 20 dBuV.	0x0014
0x1500	RDS_INT_SOURCE	Configures RDS interrupt behavior.	0x0000
0x1501	RDS_INT_FIFO_COUNT	Sets the minimum number of RDS groups stored in the receive RDS FIFO required before RDS RECV is set.	0x0000
0x1502	RDS_CONFIG	Configures RDS setting.	0x0000
0x3100	AM_DEEMPHASIS	Sets deemphasis time constant. Can be set to 50 us. Deemphasis is disabled by default.	0x0000
0x3102	AM_CHANNEL_FILTER	Selects the bandwidth of the channel filter for AM reception. The choices are 6, 4, 3, or 2 (kHz). The default bandwidth is 2 kHz.	0x0003
0x3200	AM_RSQ_INTERRUPTS	Configures interrupt related to Received Signal Quality metrics. All interrupts are disabled by default.	0x0000
0x3201	AM_RSQ_SNR_HIGH_THRESHOLD	Sets high threshold for SNR interrupt. The default is 0 dB.	0x0000
0x3202	AM_RSQ_SNR_LOW_THRESHOLD	Sets low threshold for SNR interrupt. The default is 0 dB.	0x0000
0x3203	AM_RSQ_RSSI_HIGH_THRESHOLD	Sets high threshold for RSSI interrupt. The default is 0 dB.	0x0000
0x3204	AM_RSQ_RSSI_LOW_THRESHOLD	Sets low threshold for RSSI interrupt. The default is 0 dB.	0x0000
0x3300	AM_SOFT_MUTE_RATE	Sets the rate of attack when entering or leaving soft mute. The default is 278 dB/s.	0x0040
0x3301	AM_SOFT_MUTE_SLOPE	Sets the AM soft mute slope. The bigger the number, the higher the max attenuation level. Default value is a slope of 2.	0x0002

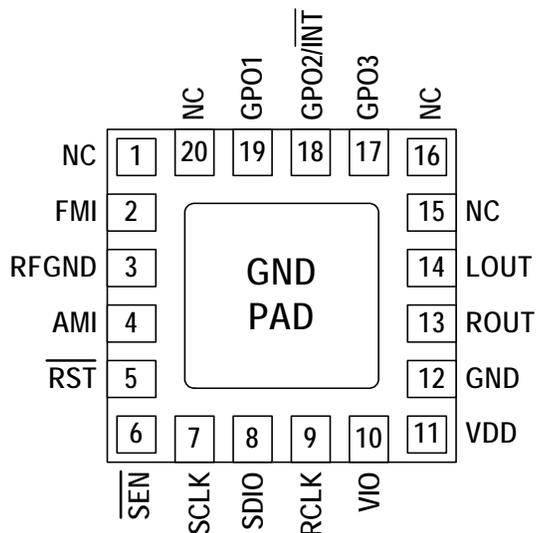
Table 13. Si473x Property Summary (Continued)

Prop	Name	Description	Default
0x3302	AM_SOFT_MUTE_MAX_ATTENUATION	Sets maximum attenuation during soft mute (dB). Set to 0 to disable soft mute. Default is 16 dB.	0x0010
0x3303	AM_SOFT_MUTE_SNR_THRESHOLD	Sets SNR threshold to engage soft mute. Default is 10 dB.	0x000A
0x3400	AM_SEEK_BAND_BOTTOM	Sets the bottom of the AM band for seek. Default is 520.	0x0208
0x3401	AM_SEEK_BAND_TOP	Sets the top of the AM band for seek. Firmware 1.0 incorrectly defaults to 1721 kHz instead of 1710.	0x06AE
0x3402	AM_SEEK_FREQ_SPACING	Selects frequency spacing for AM seek. Default is 10 kHz spacing.	0x000A
0x3403	AM_SEEK_SNR_THRESHOLD	Sets the SNR threshold for a valid AM Seek/Tune. If the value is zero then SNR threshold is not considered when doing a seek. Default value is 5 dB.	0x0005
0x3404	AM_SEEK_RSSI_THRESHOLD	Sets the RSSI threshold for a valid AM Seek/Tune. If the value is zero then RSSI threshold is not considered when doing a seek. Default value is 25 dBuV.	0x0019
0x4000	RX_VOLUME	Sets the output volume.	0x003F
0x4001	RX_HARD_MUTE	Mutes the audio output. L and R audio outputs may be muted independently in FM mode.	0x0000

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# Si4730/31-A10

## 6. Pin Descriptions: Si4730/31-GM



Pin Number(s)	Name	Description
1, 20	NC	No connect. Leave floating.
2	FMI	FM RF inputs. FMI should be connected to the antenna trace.
3	RFGND	RF ground. Connect to ground plane on PCB.
4	AMI	AM RF input. AMI should be connected to the AM antenna.
5	$\overline{\text{RST}}$	Device reset (active low) input.
6	$\overline{\text{SEN}}$	Serial enable input (active low).
7	SCLK	Serial clock input.
8	SDIO	Serial data input/output.
9	RCLK	External reference oscillator input.
10	VIO	I/O supply voltage.
11	V <sub>DD</sub>	Supply voltage. May be connected directly to battery.
12, GND PAD	GND	Ground. Connect to ground plane on PCB.
13	ROUT	Right audio line output.
14	LOUT	Left audio line output.
15, 16	NC	No connect. Leave floating.
17	GPO3	General purpose output.
18	$\overline{\text{GPO2/INT}}$	General purpose output or interrupt pin.
19	GPO1	General purpose output.

## 7. Ordering Guide

Part Number*	Description	Package Type	Operating Temperature
Si4730-A10-GM	AM/FM Broadcast Radio Receiver	QFN Pb-free	-20 to 85 C
Si4731-A10-GM	AM/FM Broadcast Radio Receiver with RDS/RBDS	QFN Pb-free	-20 to 85 C

**\*Note:** Add an "(R)" at the end of the device part number to denote tape and reel option; 2500 quantity per reel.

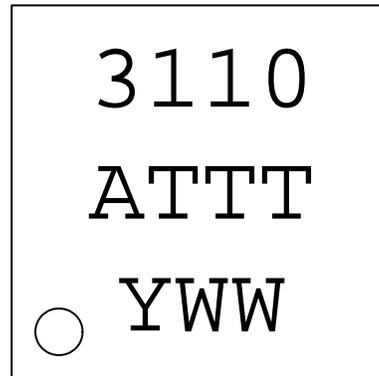
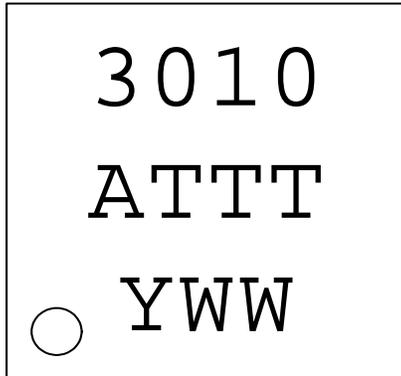
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# Si4730/31-A10

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## 8. Package Markings (Top Marks)

### 8.1. Si4730/31 Top Mark



### 8.2. Top Mark Explanation

<b>Mark Method:</b>	YAG Laser	
<b>Line 1 Marking:</b>	Part Number	30 = Si4730, 31 = Si4731
	Firmware Revision	10 = Firmware Revision 1.0
<b>Line 2 Marking:</b>	Die Revision	A = Revision A Die
	TTT = Internal Code	Internal tracking code.
<b>Line 3 Marking:</b>	Circle = 0.5 mm Diameter (Bottom-Left Justified)	Pin 1 Identifier
	Y = Year WW = Workweek	Assigned by the Assembly House. Corresponds to the last significant digit of the year and workweek of the mold date.



# Si4730/31-A10

## 10. PCB Land Pattern: Si4730/31 QFN

Figure 11 illustrates the PCB land pattern details for the Si4730/31-GM. Table 15 lists the values for the dimensions shown in the illustration.

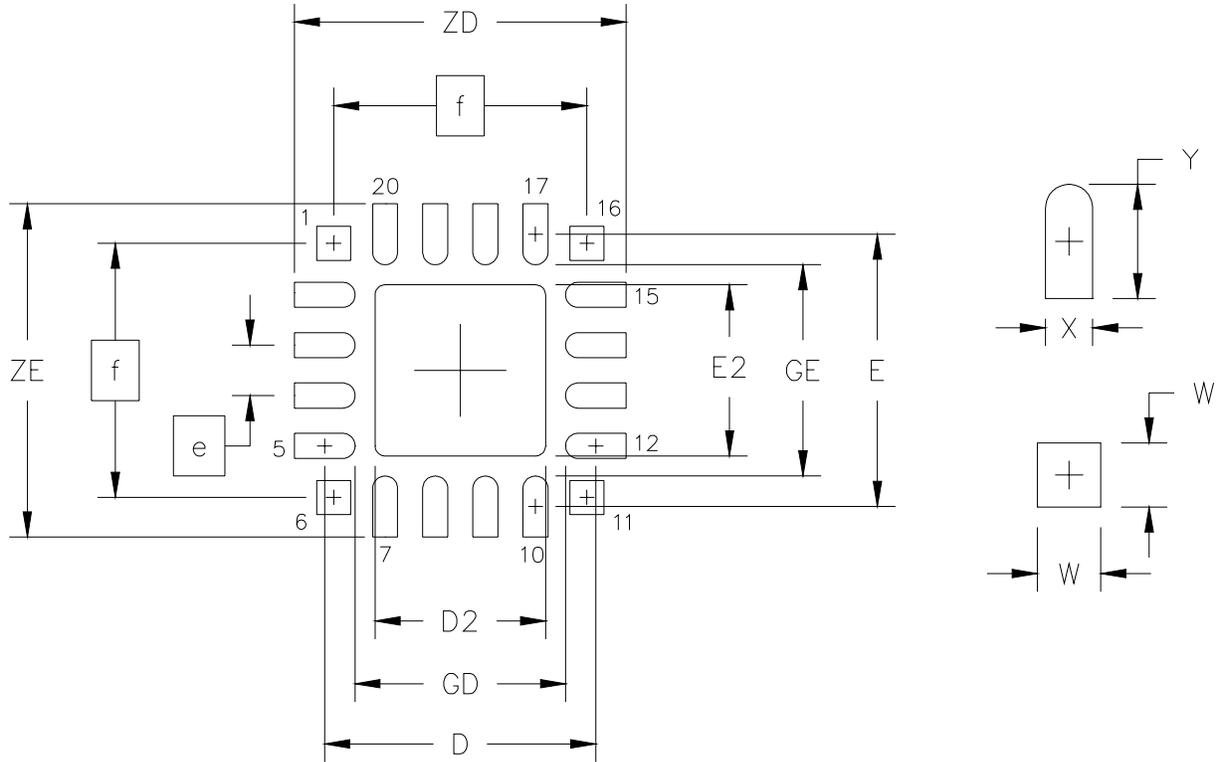


Figure 11. PCB Land Pattern

Table 15. PCB Land Pattern Dimensions

Symbol	Millimeters		Symbol	Millimeters	
	Min	Max		Min	Max
D	2.71 REF		GE	2.10	—
D2	1.60	1.80	W	—	0.34
e	0.50 BSC		X	—	0.28
E	2.71 REF		Y	0.61 REF	
E2	1.60	1.80	ZE	—	3.31
f	2.53 BSC		ZD	—	3.31
GD	2.10	—			

**Notes: General**

1. All dimensions shown are in millimeters (mm) unless otherwise noted.
2. Dimensioning and Tolerancing is per the ANSI Y14.5M-1994 specification.
3. This Land Pattern Design is based on IPC-SM-782 guidelines.
4. All dimensions shown are at Maximum Material Condition (MMC). Least Material Condition (LMC) is calculated based on a Fabrication Allowance of 0.05 mm.

**Notes: Solder Mask Design**

1. All metal pads are to be non-solder mask defined (NSMD). Clearance between the solder mask and the metal pad is to be 60  $\mu$ m minimum, all the way around the pad.

**Notes: Stencil Design**

1. A stainless steel, laser-cut and electro-polished stencil with trapezoidal walls should be used to assure good solder paste release.
2. The stencil thickness should be 0.125mm (5 mils).
3. The ratio of stencil aperture to land pad size should be 1:1 for the perimeter pads.
4. A 1.45 x 1.45 mm square aperture should be used for the center pad. This provides approximately 70% solder paste coverage on the pad, which is optimum to assure correct component stand-off.

**Notes: Card Assembly**

1. A No-Clean, Type-3 solder paste is recommended.
2. The recommended card reflow profile is per the JEDEC/IPC J-STD-020C specification for Small Body Components.

## 11. Additional Reference Resources

- Si4730/31 Revision A Errata
- AN231: Si4700/01 Headphone and Antenna Interface
- AN383: Si47xx 3 mm x 3 mm QFN Universal Layout Guide
- AN384: Si473x AM/FM Receiver Layout Guide
- AN385: Si473x AM/FM Receiver Programming Guide
- AN386: Si473x Ferrite Loop Stick Antenna Interface
- AN388: Si473x AM/FM Tuner Evaluation Board Test Procedure
- AN389: Si473x EVB Quick-Start Guide

- Si47xx Customer Support Site: <http://www.mysilabs.com>

This site contains all application notes, evaluation board schematics and layouts, and evaluation software. NDA is required for access. To request access, register at <http://www.mysilabs.com> and send user's first and last name, company, NDA reference number, and mysilabs user name to [fminfo@silabs.com](mailto:fminfo@silabs.com). Silicon Labs recommends an all lower case user name.

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## DOCUMENT CHANGE LIST

### Revision 0.3 to Revision 0.5

- Updated block diagram on page 1 and Figure 8 on page 16.
- Removed optional digital audio output and GPO functionality. These features will be supported in future firmware revisions.
- Updated Table 3, "DC Characteristics," on page 5.
- Added SPI control interface timing diagrams, Figure 6 and Figure 7.
- Updated Table 8, "FM Receiver Characteristics<sup>1,2</sup>," on page 11.
- Updated Table 9, "AM Receiver Characteristics<sup>1</sup>," on page 12.
  - Adjusted crystal frequency tolerance from +/- 200 ppm to +/- 100 ppm.
- Updated values for C5 and L2 in "3. Bill of Materials" on page 15.
- Updated "4. Functional Description" to include appropriate commands and properties.
- Updated Table 12, "Si473x Command Summary," on page 21.
- Updated Table 13, "Si473x Property Summary," on page 21.
- Updated "7. Ordering Guide" on page 25.
- Updated "11. Additional Reference Resources" on page 30.
  - Added instructions on gaining access to the secure customer website on p.29.

### Revision 0.5 to Revision 0.7

- Updated AM seek tune time.
- Updated RCLK and REFCLK details.
- Updated SPI description.
- Updated default values in Table 13, "Si473x Property Summary," on page 21.
- Added "8. Package Markings (Top Marks)" on page 26.
- Added digital audio output information.
- Updated Table 4, "Reset Timing Characteristics<sup>1,2,3</sup>," on page 6.
- Updated "4.9. RDS/RBDS Processor (Si4731 Only)" on page 18.
- Updated "6. Pin Descriptions: Si4730/31-GM" on page 24.

### Revision 0.7 to Revision 1.0

- Updated data sheet to be specific to Si4730/31-A10.
- Removed digital output information.
- Updated Table 3, "DC Characteristics," on page 5.
- Updated Table 8, "FM Receiver Characteristics<sup>1,2</sup>," on page 11.
- Updated Table 9, "AM Receiver Characteristics<sup>1</sup>," on page 12.

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